

<b>Search Notes</b> 	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>	
	10/501,960	UENISHI ET AL.	
	<b>Examiner</b> Lisa N. Klaus	<b>Art Unit</b> 2832	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
Same as above		4/26/2005	LK